Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,315	CHENG ET AL.
Examiner	Art Unit
Carry D. Ohan	2045

SEARCHED					
Class	Subclass	Date	Examiner		
38	307**	1/3/07	1		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search Report	1/07	CPC		
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